

<b>Notic of R ferences Cited</b>	Application/Control No. 09/650,604	Applicant(s)/Patent Under Reexamination KRUTSICK, THOMAS J.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,609,935	09-1986	Kondo	357/51
	B	US-5,867,087	02-1999	Wuu et al	338/311
	C	US-5,374,844	12-1994	Moyer	257/582
	D	US-4,948,747	08-1990	Pfiester	437/60
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63-58955	03-1988	Japan	Kinoshita	
	O	JP 60-128651	07-1985	Japan	Tanaka	
	P	JP 62-274654	01-1987	Japan	Eguchi	
	Q	JP 1-253950	10-1989	Japan	Nakauchi	
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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